Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10656507	OSHIMA ET AL.	
Examiner	Art Unit	
Revak Christopher A	2131	

SEARCHED						
Class		Subclass	Date	Examiner		
none	none		2/12/07	CR		

SEARCH NOTES					
Search Notes	Date	Examiner			
BRS Text Search: USPAT, US PGPUB, USOCR, DERWENT, FPRS, IBM TDB, EPO, JPO (see attached strategy)	2/12/07	CR			
Interference Search (see attached strategy)	2/12/07	CR			
DIALOG Text Search: COMPSCI, ELECTRON, SOFTWARE (see attached strategy)	2/12/07	CR			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
713	1,2,100	2/12/07	CR		
726	1-4,22-24	2/12/07	CR		
709	217-219,223,224	2/12/07	CR		
707	1,9,10,200-204	2/12/07	CR		
717	168-171,174-176	2/12/07	CR		